Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/824,366	LEE, CHANG LIM	
Examiner	Art Unit	
B. Clayton McCraw	3744	

SEARCHED				
Class	Subclass	Date	Examiner	
138	110	4/26/2006	всм	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
]		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Consulted with Primary Examiner, William Doerrler	4/26/2006	всм
Consulted with Primary Examiner, James Hook	4/26/2006	всм
Conducted Inventor Name Search	4/26/2006	всм
EAST Search Notes Attached	4/26/2006	всм